UTXS0102 Advance CMOS IC

# 2-BIT BIDIRECTIONAL VOLTAGE-LEVEL TRANSLATOR FOR OPEN-DRAIN AND PUSH-PULL APPLICATION



This 2-bit non-inverting translator is a bidirectional voltage-level translator and can be used to establish digital switching compatibility between mixed-voltage systems. It uses two separate configurable power supply rails, with the A ports supporting operating voltages from 1.65V to 3.6V while it tracks the  $V_{\text{CCA}}$  supply, and the B ports supporting operating voltages from 2.3V to 5.5V while it tracks the  $V_{\text{CCB}}$  supply.

This allows the support of both lower and higher logic signal levels while providing bidirectional translation capabilities between any of the 1.8V, 2.5V, 3.3V, and 5V voltage nodes.

When the output-enable (OE) input is low, all I/Os are placed in the high-impedance state, which significantly reduces the power-supply quiescent current consumption.

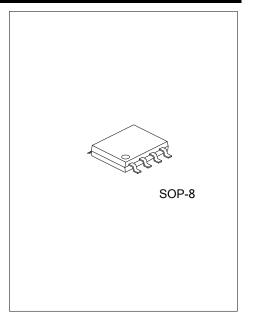
To ensure the high-impedance state during power-up or power -down, OE should be tied to GND through a pull-down resistor; the minimum value of the resistor is determined by the current-sourcing capability of the driver.

#### **■ FEATURES**

- \* 1.65V to 3.6V on A Port and 2.3V to 5.5V on B Port ( $V_{CCA} \le V_{CCB}$ )
- \* No Direction-Control Signal Needed
- \* No Power-Supply Sequencing Required Either  $V_{\text{CCA}}$  or  $V_{\text{CCB}}$  Can be Ramped First
- \* I<sub>OFF</sub> Supports Partial-Power-Down Mode Operation

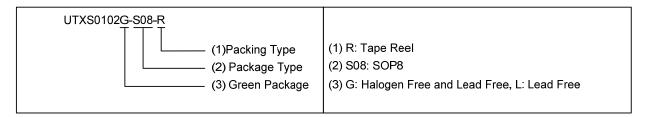
#### ■ APPLICATION

- \* Handset
- \* Smartphone
- \* Tablet
- \* Desktop PC

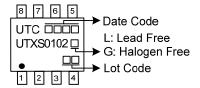


# ■ ORDERING INFORMATION

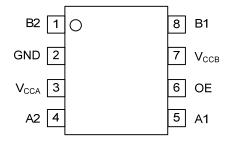
Ordering	Number	Dooksara	Doolsing
Lead Free	Halogen Free	Package	Packing
UTXS0102L-S08-R	UTXS0102G-S08-R	SOP-8	Tape Reel



# **■ MARKING**



# ■ PIN CONFIGURATION



## **■ PIN DESCRIPTION**

PIN NO.	PIN NAME	I/O	DESCRIPTION	
1	B2	I/O	Input/output B2. Referenced to V <sub>CCB</sub>	
2	GND		Ground	
3	$V_{CCA}$		A-Port supply voltage 1.65V ≤ V <sub>CCA</sub> ≤ 3.6V, V <sub>CCA</sub> ≤ V <sub>CCB</sub>	
4	A2	I/O	Input/output A2. Referenced to V <sub>CCA</sub>	
5	A1	I/O	Input/output A1. Referenced to V <sub>CCA</sub>	
6	OE	I	3-state output-mode enable. Pull OE low to place all outputs in 3-state mode. Referenced to $V_{\text{CCA}}$	
7	$V_{CCB}$		B-Port supply voltage 2.3V ≤ V <sub>CCB</sub> ≤ 5.5V	
8	B1	I/O	Input/output B1. Referenced to V <sub>CCB</sub>	

Note: I=Input, O=Output, I/O=Input and Output.

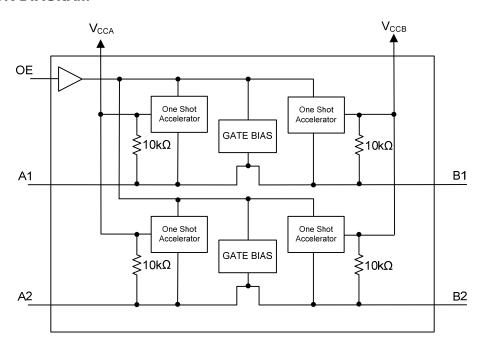
# **■ FUNCTION TABLE**

SUPPLY	SUPPLY VOLTAGE		SUPPLY VOLTAGE		SUPPLY VOLTAGE		INPUT/0	DUTPUT
$V_{CCA}$	V <sub>CCB</sub>	OE	An	Bn				
1.65V ~ V <sub>CCB</sub>	2.3V ~ 5.5V	L	Z	Z				
1.65V ~ V <sub>CCB</sub>	2.3V ~ 5.5V	Н	Input or Output	Output or Input				
GND	GND	X	Z	Z				

Notes: 1. H = High voltage level; L = Low voltage level; X = Don't care; Z = high-impedance OFF-state

2. When either V<sub>CCA</sub> or V<sub>CCB</sub> is at GND level, the device goes into power-down mode.

# **■ BLOCK DIAGRAM**



## **■ ABSOLUTE MAXIMUM RATING**

PARAMETER	PARAMETER		RATINGS	UNIT
Supply Voltage		$V_{CCA}$	-0.5 ~ 4.6	V
Supply Voltage		$V_{CCB}$	-0.5 ~ 6.5	V
lanut Valtage	A Port		-0.5 ~ 4.6	V
Input Voltage	B Port	V <sub>IN</sub>	-0.5 ~ 6.5	V
Voltage Range Applied to Any	A Port	V	-0.5 ~ 4.6	V
Output In the High-Impedance or Power-Off State	B Port	$V_{OUT}$	-0.5 ~ 6.5	V
Voltage Range Applied to Any	A Port	\ /	-0.5 ~ V <sub>CCA</sub> +0.5	V
Output In the High or Low State	B Port	$V_{OUT}$	-0.5 ~ V <sub>CCB</sub> +0.5	V
Input Clamp Current	V <sub>IN</sub> <0	I <sub>IK</sub>	-50	mA
Output Clamp Current V <sub>OUT</sub> <0		lok	-50	mA
Continuous Output Current		I <sub>OUT</sub>	±50	mA
Continuous Current Through V <sub>CCA</sub> , V <sub>CCB</sub> , or GND		I <sub>CC</sub> / I <sub>GND</sub>	±100	mA
Storage Temperature	_	$T_{STG}$	-65 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

# ■ RECOMMENDED OPERATING CONDITIONS (T<sub>A</sub>=25°C, unless otherwise specified)

PARAMETER	₹	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
Supply Voltage (Note 3)		$V_{CCA}$		1.65		3.6	V		
Supply Voltage (Note 3)		$V_{CCB}$		2.3		5.5	V		
Input Voltage		$V_{IN}$		0		V <sub>CCI</sub>	V		
Outrout Valtage	A Port I/Os	\ /	V <sub>CCA</sub> =1.65V~3.6V,	0		3.6	V		
Output Voltage	B Port I/Os	$V_{OUT}$	V <sub>CCB</sub> =2.3V~5.5V	0		5.5	V		
			V <sub>CCA</sub> =1.65V~1.95V,	V <sub>CCI</sub> -		V	V		
	A Port I/Os		V <sub>CCB</sub> =2.3V~5.5V	0.2		V <sub>CCI</sub>	V		
	A POIL I/OS		V <sub>CCA</sub> =2.3V~3.6V,	V <sub>CCI</sub> -		V <sub>CCI</sub>	V		
High-Level Input Voltage		V <sub>IH</sub>	V <sub>CCB</sub> =2.3V~5.5V	0.4		V CCI	V		
i ligii-Level lilput voltage	B Port I/Os	VIH		V <sub>CCI</sub> -		V <sub>CCI</sub>	V		
	D 1 011 1/03		V <sub>CCA</sub> =1.65V~3.6V,	0.4		V CCI	V		
	OE Input				V <sub>CCB</sub> =2.3V~5.5V	$V_{CCA}$		5.5	V
	OL IIIput			×0.65		0.0	V		
	A Port I/Os			0		0.15	V		
Low-Level Input Voltage	B Port I/Os	$V_{IL}$	V <sub>CCA</sub> =1.65V~3.6V,	0		0.15	V		
Low-Level input voitage	OE Input	V IL	V <sub>CCB</sub> =2.3V~5.5V	0		$V_{CCA}$	V		
	OL IIIput					×0.35	V		
Input Transition Disc or	A Port I/Os		V <sub>CCA</sub> =1.65V~3.6V,			10	ns/V		
Input Transition Rise or Fall Rate	B Port I/Os	Δt/Δν	V <sub>CCA</sub> =1.65V~5.6V, V <sub>CCB</sub> =2.3V~5.5V			10	ns/V		
rali Nale	OE Input		VCCB-2.3V-5.5V			10	ns/V		
Operating Temperature		$T_A$		-40		+85	°C		

Notes: 1.  $V_{\text{CCI}}$  is the supply voltage associated with the input port.

- 2.  $V_{\text{CCO}}$  is the supply voltage associated with the output port.
- 3.  $V_{\text{CCA}}$  must be less than or equal to  $V_{\text{CCB}}$ , and  $V_{\text{CCA}}$  must not exceed 3.6V.

# ■ ELECTRICAL CHARACTERISTICS (T<sub>A</sub>=25°C, unless otherwise specified)

PARAMETE	R	SYMBOL	TEST (	CONDITIONS	MIN	TYP	MAX	UNIT
Port A Output High Voltag	e	V <sub>OHA</sub>	$V_{CCA}=1.65V\sim 3$ $V_{CCB}=2.3V\sim 5$ . $V_{IB} \ge V_{CCB}=0.4$	5V, I <sub>OH</sub> =-20μA,	V <sub>CCA</sub> ×0.67			V
Port A Output Low Voltag	e	V <sub>OLA</sub>	$V_{CCA}=1.65V\sim 3$ $V_{CCB}=2.3V\sim 5$ . $V_{IB} \le 0.15V$	•			0.4	٧
Port B Output High Voltag	le	V <sub>OHB</sub>	$V_{CCA}=1.65V\sim 3$ $V_{CCB}=2.3V\sim 5$ . $V_{IA} \ge V_{CCA}=0.2$	5V, I <sub>OH</sub> =-20μA	V <sub>CCB</sub> ×0.67			٧
Port B Output Low Voltag	e	$V_{OLB}$	$V_{CCA}=1.65V\sim 3$ $V_{CCB}=2.3V\sim 5$ . $V_{IA} \le 0.15V$	•			0.4	V
Input Leakage Current	OE	I <sub>I(LEAK)</sub>	V <sub>CCA</sub> =1.65V~3 V <sub>CCB</sub> =2.3V~5.	•			±1	μΑ
Power OFF Leakage	A Port	I <sub>OFF</sub>	V <sub>CCA</sub> =0V, V <sub>CCI</sub>				±1	μΑ
Current	B Port	IOFF	V <sub>CCA</sub> =0V~3.6\	/, V <sub>CCB</sub> =0V			±1	μΑ
High-Impedance State Output Current	A or B Port	l <sub>oz</sub>	V <sub>CCA</sub> =1.65V~3.6V, V <sub>CCB</sub> =2.3V~5.5V, OE=GND				±1	μΑ
				V <sub>CCA</sub> =1.65V~V <sub>CCB</sub> , V <sub>CCB</sub> =2.3V~5.5V			2.4	μΑ
		I <sub>CCA</sub>		V <sub>CCA</sub> =3.6V, V <sub>CCB</sub> =0V			2.2	μΑ
			V <sub>I</sub> =V <sub>O</sub> =Open,	V <sub>CCA</sub> =0V, V <sub>CCB</sub> =5.5V			-1	μA
Supply Current			I <sub>O</sub> =0A	$V_{CCA}$ =1.65V~ $V_{CCB}$ , $V_{CCB}$ =2.3V~5.5V			12	μA
		I <sub>CCB</sub>		V <sub>CCA</sub> =3.6V, V <sub>CCB</sub> =0V			-1	μA
				V <sub>CCA</sub> =0V, V <sub>CCB</sub> =5.5V			1	μA
		I <sub>CCA</sub> +I <sub>CCB</sub>	V <sub>I</sub> =V <sub>CCI</sub> or GND, I <sub>O</sub> =0A	V <sub>CCA</sub> =1.65V~V <sub>CCB</sub> , V <sub>CCB</sub> =2.3V~5.5V			14.4	μΑ
Input Capacitance	OE	C <sub>IN</sub>	V <sub>CCA</sub> =3.3V, V <sub>C</sub>	<sub>CCB</sub> =3.3V		2.5		pF
Output Capacitance	A Port B Port	C <sub>IO</sub>	V <sub>CCA</sub> =3.3V, V <sub>C</sub>			5 6		pF pF
B Port		Second 20 October 1 and			l			וא

Notes: 1.  $V_{\text{CCI}}$  is the supply voltage associated with the input port.

<sup>2.</sup>  $V_{\text{CCO}}$  is the supply voltage associated with the output port.

<sup>3.</sup>  $V_{\text{CCA}}$  must be less than or equal to  $V_{\text{CCB}}$ , and  $V_{\text{CCA}}$  must not exceed 3.6V.

# ■ **SWITCHING CHARACTERISTICS** (T<sub>A</sub>=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CC	ONDITIONS	MIN	TYP	MAX	UNIT
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V			5.3	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V			5.4	ns
	Driving		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =5V±0.5V			6.8	ns
	Open-Drain		V <sub>CCA</sub> =1.6V±0.15V	V <sub>CCB</sub> =2.5V±0.2V	2.3		8.8	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	2.4		9.6	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	2.6		10	ns
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V			3.2	ns
Propagation Delay	Driving			V <sub>CCB</sub> =3.3V±0.3V			3.7	ns
From Input (A) to Output (B)	Driving		V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =5V±0.5V			3.8	ns
	Open-Drain		VCCA-2.5V±0.2V	V <sub>CCB</sub> =2.5V±0.2V	1.7		6.3	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	2.0		6.0	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	2.1		5.8	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V			2.4	ns
	Driving		V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =5V±0.5V			3.1	ns
	Open-Drain		VCCA-3.3V±0.3V	V <sub>CCB</sub> =3.3V±0.3V	1.3		4.2	ns
	Driving	<b>+</b>		V <sub>CCB</sub> =5V±0.5V	1.4		4.6	ns
	Push-Pull	t <sub>PHL</sub>		V <sub>CCB</sub> =2.5V±0.2V			4.4	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V			4.5	ns
	Driving		\/ -1.0\/\\0.15\/	V <sub>CCB</sub> =5V±0.5V			4.7	ns
	Open-Drain		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =2.5V±0.2V	1.9		5.3	ns
	Driving Push-Pull Driving	_		V <sub>CCB</sub> =3.3V±0.3V	1.1		4.4	ns
				V <sub>CCB</sub> =5V±0.5V	1.2		4.0	ns
				V <sub>CCB</sub> =2.5V±0.2V			3.0	ns
Propagation Delay				V <sub>CCB</sub> =3.3V±0.3V			3.6	ns
From Input (B) to Output (A)	Driving		V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =5V±0.5V			4.3	ns
	Open-Drain		V <sub>CCA</sub> -2.5V±0.2V	V <sub>CCB</sub> =2.5V±0.2V	1.8		4.7	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	2.6		4.2	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	1.2		4.0	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V			2.5	ns
	Driving		\/3 3\/±0 3\/	V <sub>CCB</sub> =5V±0.5V			3.3	ns
	Open-Drain		V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =3.3V±0.3V	1.0		124	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	1.0		97	ns
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V			6.8	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V			7.1	ns
	Briving		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =5V±0.5V			7.5	ns
	Open-Drain		V CCA-1.0 V ±0.10 V	V <sub>CCB</sub> =2.5V±0.2V	45		260	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	36		208	ns
Propagation Delay From Input (A) to Output (B)				V <sub>CCB</sub> =5V±0.5V	27		198	ns
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V			3.5	ns
	Driving	t <sub>PLH</sub>		V <sub>CCB</sub> =3.3V±0.3V			4.1	ns
	29	YFLH	V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =5V±0.5V			4.4	ns
	Open-Drain		VOCA 2.0V±0.2V	V <sub>CCB</sub> =2.5V±0.2V	43		250	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	36		206	ns
	מוואוום			V <sub>CCB</sub> =5V±0.5V	27		190	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V			4.2	ns
	Driving	1	V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =5V±0.5V			4.4	ns
	Open-Drain		v <sub>CCA</sub> -3.3v±0.3V	V <sub>CCB</sub> =3.3V±0.3V	36		204	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	28		165	ns

# **CMOS IC**

# ■ SWITCHING CHARACTERISTICS (Cont.)

PARAMETER		SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNIT
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V			5.3	ns
				V <sub>CCB</sub> =3.3V±0.3V			4.5	ns
	Driving		1 0 1 0 1 5 1	V <sub>CCB</sub> =5V±0.5V			0.5	ns
	On an Dunin		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =2.5V±0.2V	45		175	ns
	Open-Drain			V <sub>CCB</sub> =3.3V±0.3V	36		140	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	27		102	ns
	December Death			V <sub>CCB</sub> =2.5V±0.2V			2.5	ns
Propagation Delay	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V			1.6	ns
From Input (B) to Output (A)	Driving	t <sub>PLH</sub>	), –0.5), 0.0),	V <sub>CCB</sub> =5V±0.5V			1.0	ns
	On an Dunin		V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =2.5V±0.2V	44		170	ns
	Open-Drain			V <sub>CCB</sub> =3.3V±0.3V	37		140	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	27		103	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V			2.5	ns
	Driving		0.004.004	V <sub>CCB</sub> =5V±0.5V			2.6	ns
	Open-Drain		V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =3.3V±0.3V	3.0		139	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	3.0		105	ns
				V <sub>CCB</sub> =2.5V±0.2V			200	ns
			V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =3.3V±0.3V			200	ns
			00/1	V <sub>CCB</sub> =5V±0.5V			200	ns
Enable Time		t <sub>en</sub>	V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =2.5V±0.2V			200	ns
From Input (OE) to Output (A	or B)			V <sub>CCB</sub> =3.3V±0.3V			200	ns
				V <sub>CCB</sub> =5V±0.5V			200	ns
			// -3 3/40 3//	V <sub>CCB</sub> =3.3V±0.3V			200	ns
			V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =5V±0.5V			200	ns
			V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =2.5V±0.2V			50	ns
				V <sub>CCB</sub> =3.3V±0.3V			40	ns
				V <sub>CCB</sub> =5V±0.5V			35	ns
Disable Time			V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =2.5V±0.2V			50	ns
From Input (OE) to Output (A	or B)	t <sub>dis</sub>		V <sub>CCB</sub> =3.3V±0.3V			40	ns
				V <sub>CCB</sub> =5V±0.5V			35	ns
				V <sub>CCB</sub> =3.3V±0.3V			40	ns
			V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =5V±0.5V			35	ns
	D . I D II			V <sub>CCB</sub> =2.5V±0.2V	3.2		9.5	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V	2.3		9.3	ns
	Driving		1 0) (10 45) (	V <sub>CCB</sub> =5V±0.5V	2.0		7.6	ns
	On an Dunin		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =2.5V±0.2V	38		165	ns
Input Rise Time (A Port Rise Time)  Open-D	Open-Drain			V <sub>CCB</sub> =3.3V±0.3V	30		132	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	22		95	ns
	D . I D II			V <sub>CCB</sub> =2.5V±0.2V	2.8		7.4	ns
				V <sub>CCB</sub> =3.3V±0.3V	2.6		6.6	ns
	Driving	t <sub>rA</sub>	0.5)/.00)/	V <sub>CCB</sub> =5V±0.5V	1.8		5.6	ns
	On an Dunin		V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =2.5V±0.2V	3.0		149	ns
	Open-Drain			V <sub>CCB</sub> =3.3V±0.3V	28		121	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	24		89	ns
	Push-Pull		-	V <sub>CCB</sub> =3.3V±0.3V	2.3		5.6	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	1.9		4.8	ns
	Open-Drain		V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =3.3V±0.3V	25		116	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	19		85	ns

# ■ SWITCHING CHARACTERISTICS (Cont.)

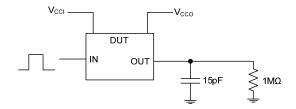
PARAMETER		SYMBOL	TEST CC	ONDITIONS	MIN	TYP	MAX	UNIT
	December Death			V <sub>CCB</sub> =2.5V±0.2V	4.0		10.8	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V	2.7		9.1	ns
	Driving		1 0 1 0 4 5 1	V <sub>CCB</sub> =5V±0.5V	2.7		7.6	ns
	On on Droin		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =2.5V±0.2V	34		145	ns
	Open-Drain Driving			V <sub>CCB</sub> =3.3V±0.3V	23		106	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	10		58	ns
	Duck Dull			V <sub>CCB</sub> =2.5V±0.2V	3.2		8.3	ns
Input Rise Time	Push-Pull Driving			V <sub>CCB</sub> =3.3V±0.3V	2.9		7.2	ns
(B Port Rise Time)	Driving	t <sub>rB</sub>	V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =5V±0.5V	2.4		6.1	ns
	Open-Drain		VCCA-2.3V10.2V	V <sub>CCB</sub> =2.5V±0.2V	35		151	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	24		112	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	12		64	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V	2.5		6.4	ns
	Driving		V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =5V±0.5V	2.1		7.4	ns
	Open-Drain		V CCA-3.3 V ±0.3 V	V <sub>CCB</sub> =3.3V±0.3V	26		116	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	14		72	ns
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V	2.0		5.9	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	1.9		6.0	ns
	Diving		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =5V±0.5V	1.7		13.3	ns
	Open-Drain Driving	- t <sub>fA</sub>	VCCA 1.5V15.16V	V <sub>CCB</sub> =2.5V±0.2V	4.4		6.9	ns
				V <sub>CCB</sub> =3.3V±0.3V	4.3		6.4	ns
	Enving			V <sub>CCB</sub> =5V±0.5V	4.2		6.1	ns
Input Fall Time	Push-Pull Driving			V <sub>CCB</sub> =2.5V±0.2V	1.9		5.7	ns
				V <sub>CCB</sub> =3.3V±0.3V	1.9		5.5	ns
(A Port Fall Time)			V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =5V±0.5V	1.8		5.3	ns
	Open-Drain		30/1	V <sub>CCB</sub> =2.5V±0.2V	4.4		6.9	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	4.3		6.2	ns
				V <sub>CCB</sub> =5V±0.5V	4.2		5.8	ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V	2.0		5.4	ns
	Driving		V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =5V±0.5V	1.9		5.0	ns
	Open-Drain			V <sub>CCB</sub> =3.3V±0.3V	4.3		6.1	ns
	Driving			V <sub>CCB</sub> =5V±0.5V	4.2		5.7	ns
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V	2.9		13.8	ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	2.8		16.2	ns
	-		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =5V±0.5V	2.8		16.2	ns
	Open-Drain			V <sub>CCB</sub> =2.5V±0.2V	6.9		13.8	ns
Input Fall Time (B Port Fall Time)	Driving			V <sub>CCB</sub> =3.3V±0.3V	7.5		16.2	ns
				V <sub>CCB</sub> =5V±0.5V	7.0		16.2	ns
	Push-Pull			$V_{CCB}=2.5V\pm0.2V$	2.2		7.8 6.7	ns
	Driving	$t_fB$		V <sub>CCB</sub> =3.3V±0.3V				ns
			V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =5V±0.5V V <sub>CCB</sub> =2.5V±0.2V	2.6 5.1		6.6 8.8	ns
	Open-Drain Driving Push-Pull			V <sub>CCB</sub> =2.5V±0.2V V <sub>CCB</sub> =3.3V±0.3V	5.4		9.4	ns ne
		_		V <sub>CCB</sub> =5.3V±0.5V	5.4		10.4	ns ne
				V <sub>CCB</sub> =3.3V±0.3V	2.3		7.4	ns ns
	Driving			V <sub>CCB</sub> =5.3V±0.5V	2.4		7.4	ns
	Open-Drain	1	V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =3.3V±0.3V	5.0		7.6	ns
	Driving			V <sub>CCB</sub> =5.3V±0.5V	4.8		8.3	ns
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# ■ SWITCHING CHARACTERISTICS (Cont.)

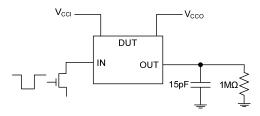
PARAMETER		SYMBOL	TEST CC	ONDITIONS	MIN	TYP	MAX	UNIT
	Duch Dull			V <sub>CCB</sub> =2.5V±0.2V			21	Mbps
	Push-Pull Driving	"	V <sub>CCB</sub> =3.3V±0.3V			22	Mbps	
Data Rate	Driving	f <sub>data</sub>		V <sub>CCB</sub> =5V±0.5V			24	Mbps
Dala Rale	Open-drain	Idata		V <sub>CCB</sub> =2.5V±0.2V			2	Mbps
	Driving			V <sub>CCB</sub> =3.3V±0.3V			2	Mbps
	Dilving		V <sub>CCA</sub> =1.8V±0.15V	V <sub>CCB</sub> =5V±0.5V			2	Mbps
	Push-Pull		V <sub>CCA</sub> -1.6V±0.15V	V <sub>CCB</sub> =2.5V±0.2V	47			ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	45			ns
Pulse Duration	Dilving	t <sub>w</sub>		V <sub>CCB</sub> =5V±0.5V	41			ns
i dise Duration	Open-drain	ιw		V <sub>CCB</sub> =2.5V±0.2V	500			ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	500			ns
	Dilving			V <sub>CCB</sub> =5V±0.5V	500			ns
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V			20	Mbps
	Driving		─V <sub>CCA</sub> =2.5V±0.2V	V <sub>CCB</sub> =3.3V±0.3V			22	Mbps
Data Rate	Bilving	f <sub>data</sub>		V <sub>CCB</sub> =5V±0.5V			24	Mbps
	Open-drain			V <sub>CCB</sub> =2.5V±0.2V			2	Mbps
	Driving			V <sub>CCB</sub> =3.3V±0.3V			2	Mbps
	Bilving			V <sub>CCB</sub> =5V±0.5V			2	Mbps
	Push-Pull			V <sub>CCB</sub> =2.5V±0.2V	50			ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	45			ns
Pulse Duration	Bilving	t <sub>w</sub>		V <sub>CCB</sub> =5V±0.5V	41			ns
l disc Baration	Open-drain	LVV		V <sub>CCB</sub> =2.5V±0.2V	500			ns
	Driving			V <sub>CCB</sub> =3.3V±0.3V	500			ns
	Dilving			V <sub>CCB</sub> =5V±0.5V	500			ns
	Push-Pull			V <sub>CCB</sub> =3.3V±0.3V			23	Mbps
Data Rate	Driving	f <sub>data</sub>		V <sub>CCB</sub> =5V±0.5V			24	Mbps
Data Nate	Open-drain	data		V <sub>CCB</sub> =3.3V±0.3V			2	Mbps
	Driving		V <sub>CCA</sub> =3.3V±0.3V	V <sub>CCB</sub> =5V±0.5V			2	Mbps
	Push-Pull		VCCA-3.3V±0.3V	V <sub>CCB</sub> =3.3V±0.3V	43			ns
Pulse Duration	Driving	t <sub>w</sub>		V <sub>CCB</sub> =5V±0.5V	41			ns
I disc Duration	Open-drain	ιW		V <sub>CCB</sub> =3.3V±0.3V	500			ns
Drivin	Driving			V <sub>CCB</sub> =5V±0.5V	500			ns

## **■ TEST CIRCUIT AND WAVEFORMS**

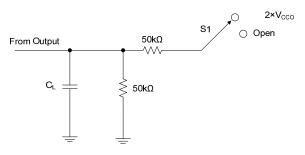
## **Load Circuits**



Data Rate, Pulse Duration, Propagation Delay, Output Rise-Time and Fall-Time Measurement Using a Push-Pull Driver



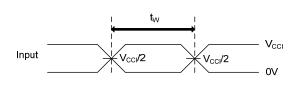
Data Rate, Pulse Duration, Propagation Delay, Output Rise-Time and Fall-Time Measurement Using an Open-Drain Driver



TEST	S1
t <sub>PLZ</sub> /t <sub>PZL</sub>	2×V <sub>cco</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	Open

Notes: 1. C<sub>L</sub> includes probe and jig capacitance.

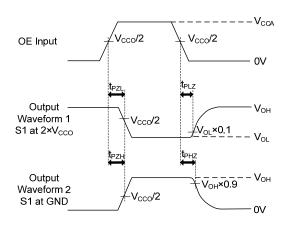
- 2.  $t_{en}$  is the same as  $t_{PZL}$  and  $t_{PZH}$ .  $t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .
- 3. V<sub>CCI</sub> is the supply voltage associated with the input.
- 4.  $V_{\text{CCO}}$  is the supply voltage associated with the input.



Input  $V_{CC}/2$   $V_{$ 

**PULSE DURATION** 

**PROPAGATION DELAY TIMES** 



**ENABLE AND DISABLE TIMES** 

 $V_{\text{CCI}}$ 

#### DETAILED DESCRIPTION

#### Overview

The **UTXS0102** device is a directionless voltage-level translator specifically designed for translating logic voltage levels. The A port is able to accept I/O voltages ranging from 1.65V to 3.6V, while the B port can accept I/O voltages from 2.3V to 5.5V. The device is a pass gate architecture with edge rate accelerators (one shots) to improve the overall data rate.  $10k\Omega$  pull-up resistors, commonly used in open-drain applications, have been conveniently integrated so that an external resistor is not needed. While this device is designed for open-drain applications, the device can also translate push-pull CMOS logic outputs.

#### **Architecture**

The **UTXS0102** architecture does not require a direction-control signal to control the direction of data flow from A to B or from B to A.

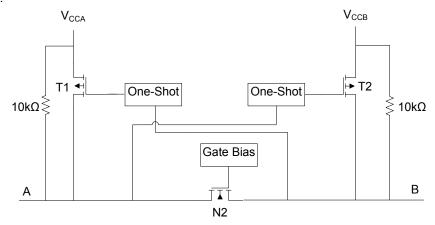


Figure 1. Architecture of UTXS0102 I/O Cell

Each A-port I/O has an internal  $10k\Omega$  pull up resistor to  $V_{CCA}$ , and each B-port I/O has an internal  $10k\Omega$  pull-up resistor to  $V_{CCB}$ . The output one-shots detect rising edges on the A or B ports. During a rising edge, the one-shot turns on the PMOS transistors (T1, T2) for a short duration, which speeds up the low-to-high transition.

#### **Input Driver Requirements**

The fall time  $(t_{fA}, t_{fB})$  of a signal depends on the output impedance of the external device driving the data I/Os of the **UTXS0102**. Similarly, the  $t_{PHL}$  and max data rates also depend on the output impedance of the external driver. The values for  $t_{fA}$ ,  $t_{fB}$ ,  $t_{PHL}$ , and maximum data rates in the data sheet assume that the output impedance of the external driver is less than  $50\Omega$ .

#### Power-Up

During operation, ensure that  $V_{CCA} \le V_{CCB}$  at all times. During power-up sequencing,  $V_{CCA} \ge V_{CCB}$  does not damage the device, so any power supply can be ramped up first.

## **Enable and Disable**

The **UTXS0102** has an OE input that is used to disable the device by setting OE low, which places all I/Os in the Hi-Z state. The disable time  $(t_{dis})$  indicates the delay between the time when OE goes low and when the outputs actually get disabled(Hi-Z). The enable time  $(t_{en})$  indicates the amount of time the user must allow for the one-shot circuitry to become operational after OE is taken high.

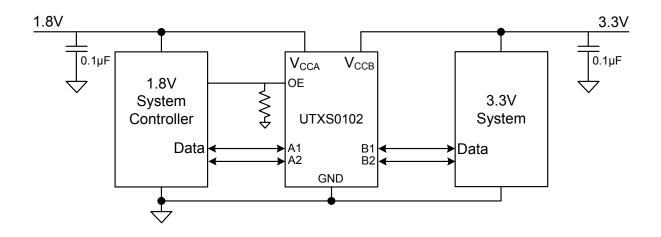
## Pull-up or Pull-down Resistors on I/O Lines

Each A-port I/O has an internal  $10k\Omega$  pull-up resistor to  $V_{CCA}$ , and each B-port I/O has an internal  $10~k\Omega$  pull-up resistor to  $V_{CCB}$ . If a smaller value of pull-up resistor is required, an external resistor must be added from the I/O to  $V_{CCA}$  or  $V_{CCB}$  (in parallel with the internal  $10~k\Omega$  resistors).

## **Device Functional Modes**

The **UTXS0102** device has two functional modes, enabled and disabled. To disable the device set the OE input low, which places all I/Os in a high impedance state. Setting the OE input high will enable the device.

## ■ TYPICAL APPLICATION CIRCUIT



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